



18. TEST PHOTOGRAPHS

See following Attached Pages for setup photographs.

FCC ID: A3LSMJ320P	 PCTEST ENGINEERING LABORATORY, INC.	HAC (RF EMISSIONS) TEST REPORT		Reviewed by: Quality Manager
Filename: 0Y1510121879 -R1.A3L	Test Dates: 10/12/2015 - 10/14/2015	EUT Type: Portable Handset	Page 59 of 61	

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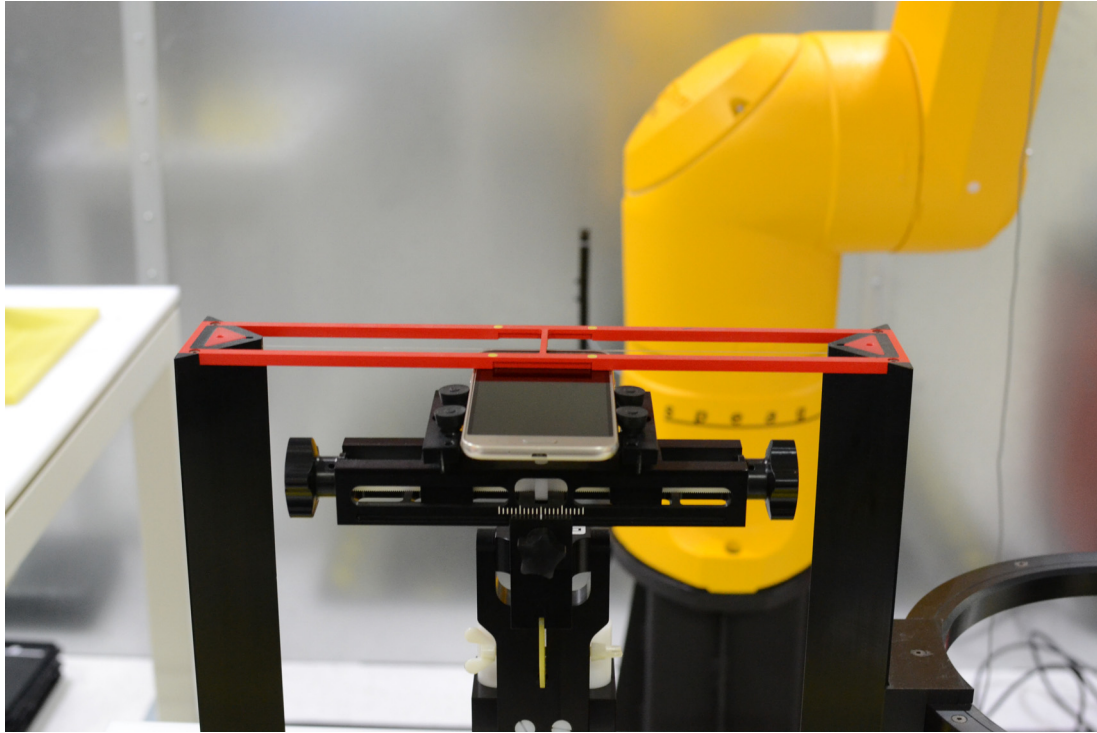


Figure 18-1
Ear Reference Point HAC Phantom Alignment

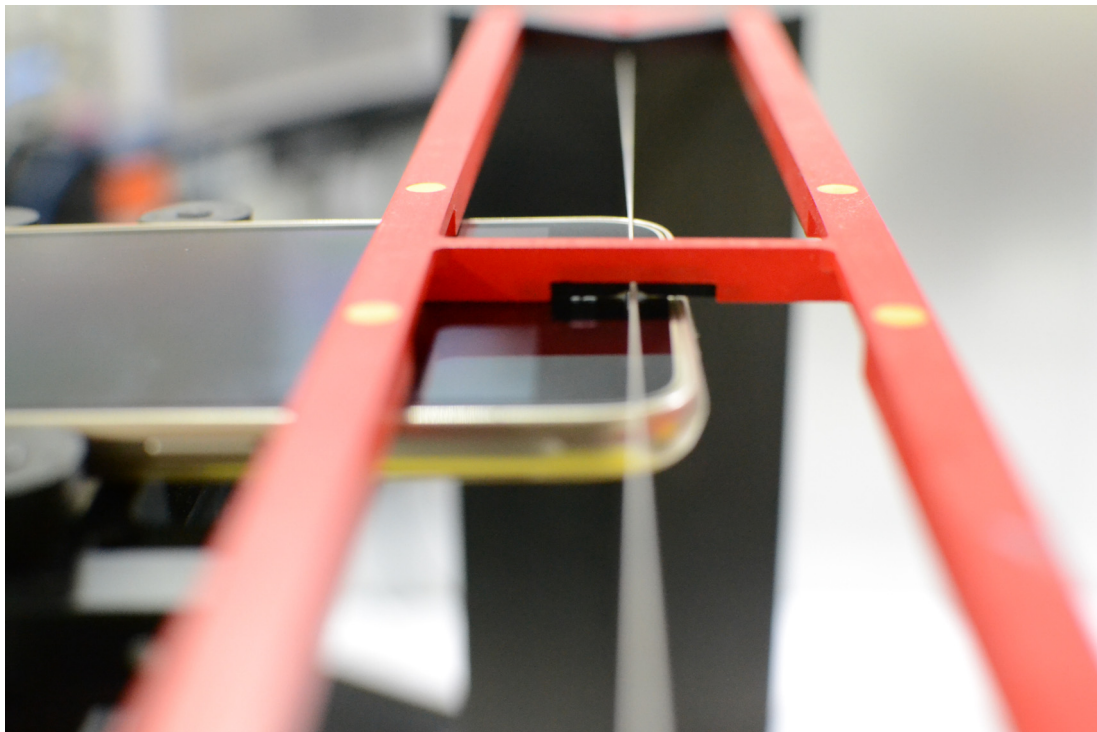




Figure 18-2
HAC Phantom Plane Alignment

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Figure 18-3 5x5 Scan grid above WD



Figure 18-4 E-Field WD Scan overlay

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